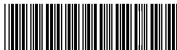


Search Notes**Application/Control No.**

10/816,450

Examiner

BENJAMIN P. GEIB

**Applicant(s)/Patent under
Reexamination**

CHUN ET AL.

Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
712	245	4/28/2008	BPG

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search	4/28/2008	BPG
Updated NPL search (Google Scholar, IEEE Xplore, CiteSeer)	4/28/2008	BPG
Inventor name search	4/28/2008	BPG